

## Excellent Integrated System Limited

Stocking Distributor

Click to view price, real time Inventory, Delivery & Lifecycle Information:

[International Rectifier \(Infineon Technologies Americas Corp.\)  
IRF1404ZGPBF](#)

For any questions, you can email us directly:

[sales@integrated-circuit.com](mailto:sales@integrated-circuit.com)

# International IR Rectifier

PD - 96236A

## IRF1404ZGPbF

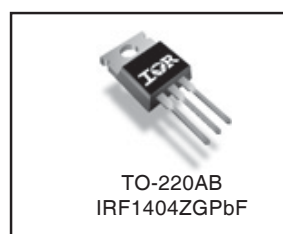
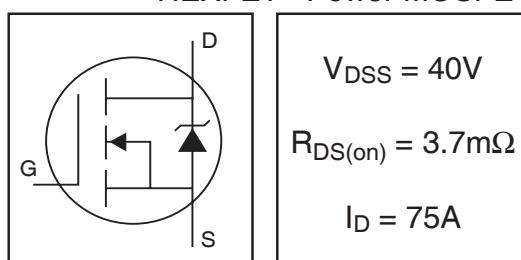
### Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free
- Halogen-Free

### Description

This HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in a wide variety of applications.

### HEXFET® Power MOSFET



### Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited)	190	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	130	
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Package Limited)	75	
$I_{DM}$	Pulsed Drain Current <sup>①</sup>	750	
$P_D @ T_C = 25^\circ C$	Power Dissipation	220	W
	Linear Derating Factor	1.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$ (Thermally limited)	Single Pulse Avalanche Energy <sup>②</sup>	320	mJ
$E_{AS}$ (Tested)	Single Pulse Avalanche Energy Tested Value <sup>③</sup>	480	
$I_{AR}$	Avalanche Current <sup>①</sup>	See Fig.12a, 12b, 15, 16	A
$E_{AR}$	Repetitive Avalanche Energy <sup>⑤</sup>		mJ
$T_J$	Operating Junction and	-55 to + 175	°C
$T_{STG}$	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw <sup>⑦</sup>	10 lbf•in (1.1N•m)	

### Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	0.65	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface <sup>⑧</sup>	0.50	—	
$R_{\theta JA}$	Junction-to-Ambient <sup>⑨</sup>	—	62	

# IRF1404ZGPbF

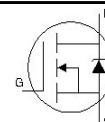
 International  

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.033	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	2.7	3.7	m $\Omega$	$V_{GS} = 10V, I_D = 75A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
$g_{fs}$	Forward Transconductance	170	—	—	V	$V_{DS} = 25V, I_D = 75A$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	20	$\mu A$	$V_{DS} = 40V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 40V, V_{GS} = 0V, T_J = 125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{GS} = -20V$
$Q_g$	Total Gate Charge	—	100	150	nC	$I_D = 75A$
$Q_{gs}$	Gate-to-Source Charge	—	31	—		$V_{DS} = 32V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	42	—		$V_{GS} = 10V$ ③
$t_{d(on)}$	Turn-On Delay Time	—	18	—	ns	$V_{DD} = 20V$
$t_r$	Rise Time	—	110	—		$I_D = 75A$
$t_{d(off)}$	Turn-Off Delay Time	—	36	—		$R_G = 3.0\ \Omega$
$t_f$	Fall Time	—	58	—		$V_{GS} = 10V$ ③
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	4340	—	pF	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	1030	—		$V_{DS} = 25V$
$C_{rss}$	Reverse Transfer Capacitance	—	550	—		$f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	3300	—		$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$
$C_{oss}$	Output Capacitance	—	920	—		$V_{GS} = 0V, V_{DS} = 32V, f = 1.0\text{MHz}$
$C_{oss\ eff.}$	Effective Output Capacitance	—	1350	—		$V_{GS} = 0V, V_{DS} = 0V\ \text{to}\ 32V$ ④

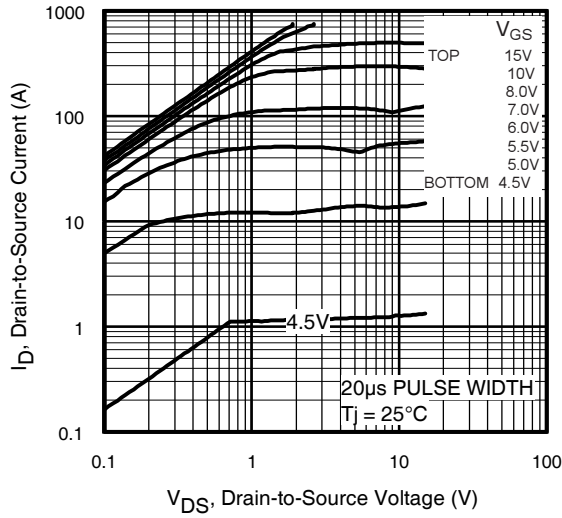
**Source-Drain Ratings and Characteristics**

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	75	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	750		
$V_{SD}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 75A, V_{GS} = 0V$ ③
$t_{rr}$	Reverse Recovery Time	—	28	42	ns	$T_J = 25^\circ\text{C}, I_F = 75A, V_{DD} = 20V$
$Q_{rr}$	Reverse Recovery Charge	—	34	51	nC	$di/dt = 100A/\mu s$ ③
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ )				

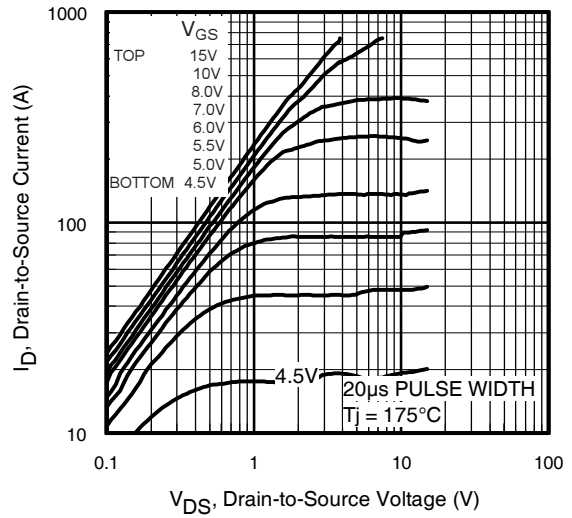


International  
**IR** Rectifier

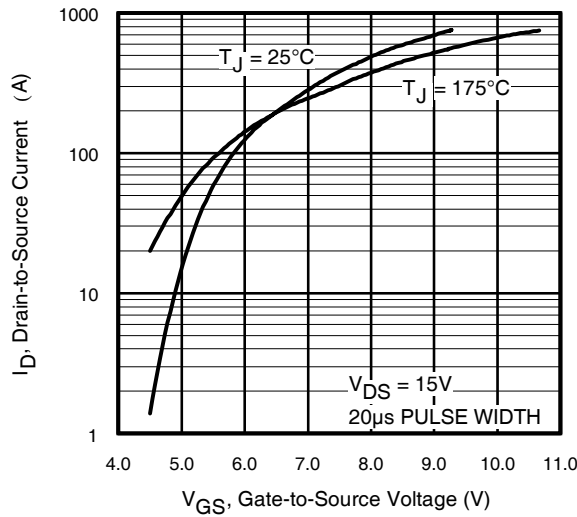
# IRF1404ZGPbF



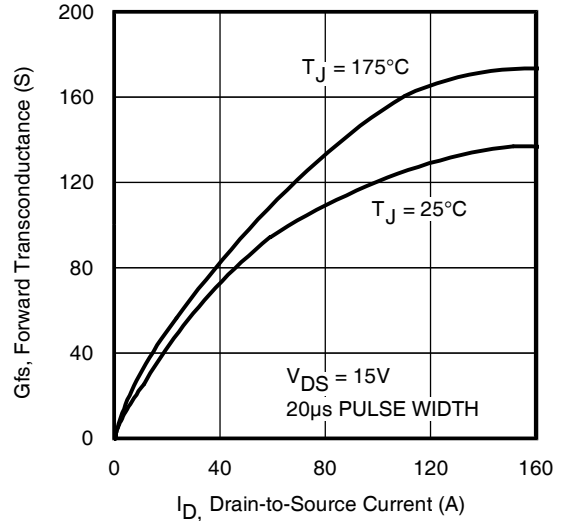
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



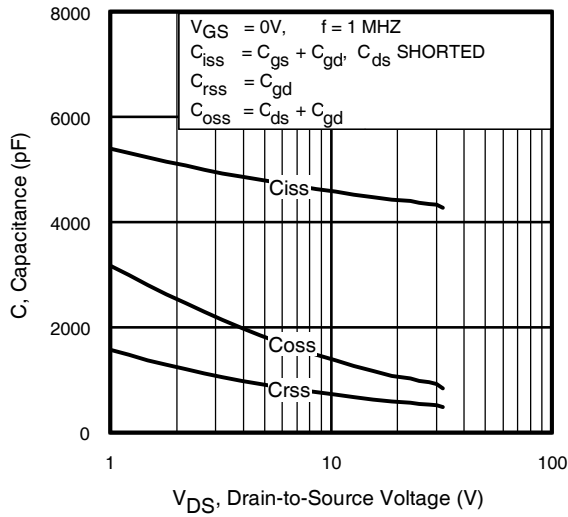
**Fig 3.** Typical Transfer Characteristics



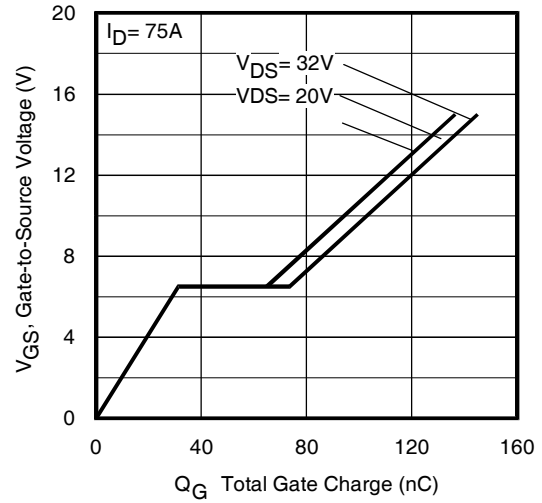
**Fig 4.** Typical Forward Transconductance Vs. Drain Current

# IRF1404ZGPbF

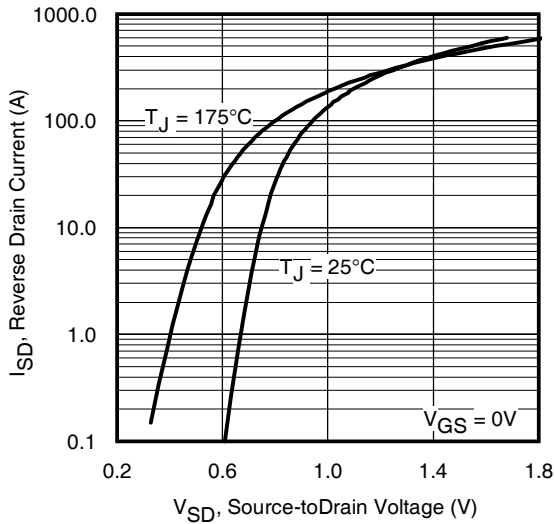
International  
**IR** Rectifier



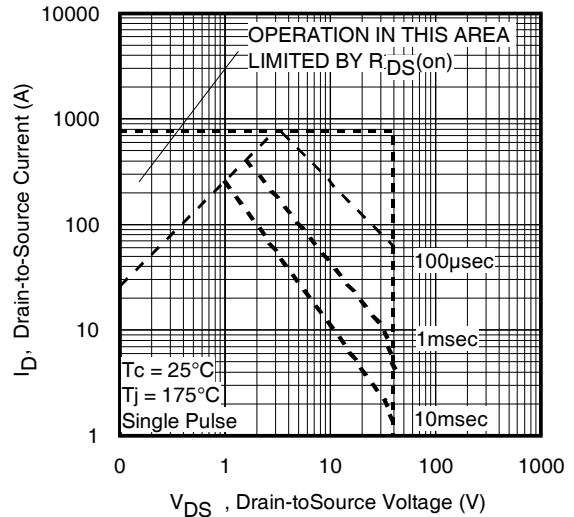
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



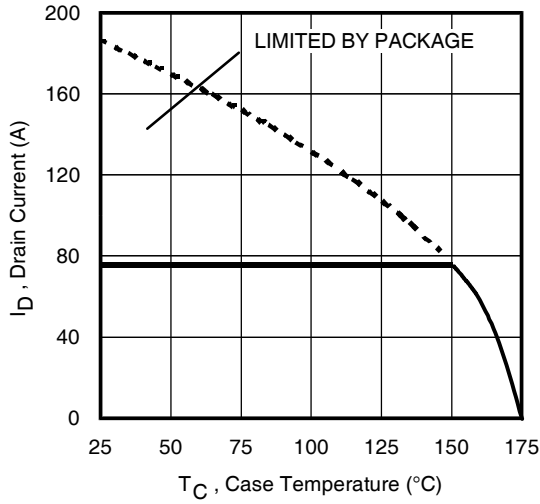
**Fig 7.** Typical Source-Drain Diode Forward Voltage



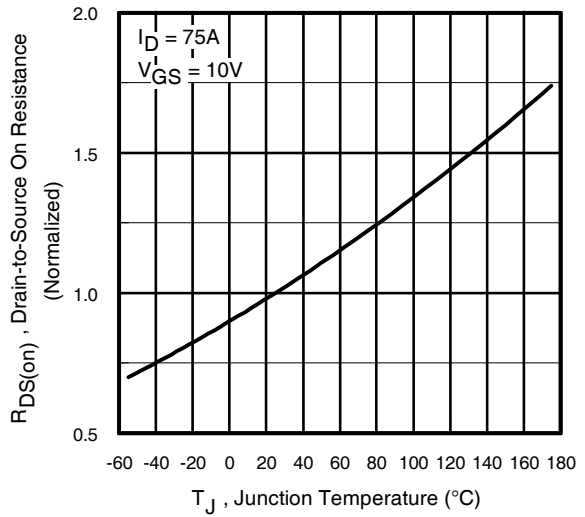
**Fig 8.** Maximum Safe Operating Area

International  
**IR** Rectifier

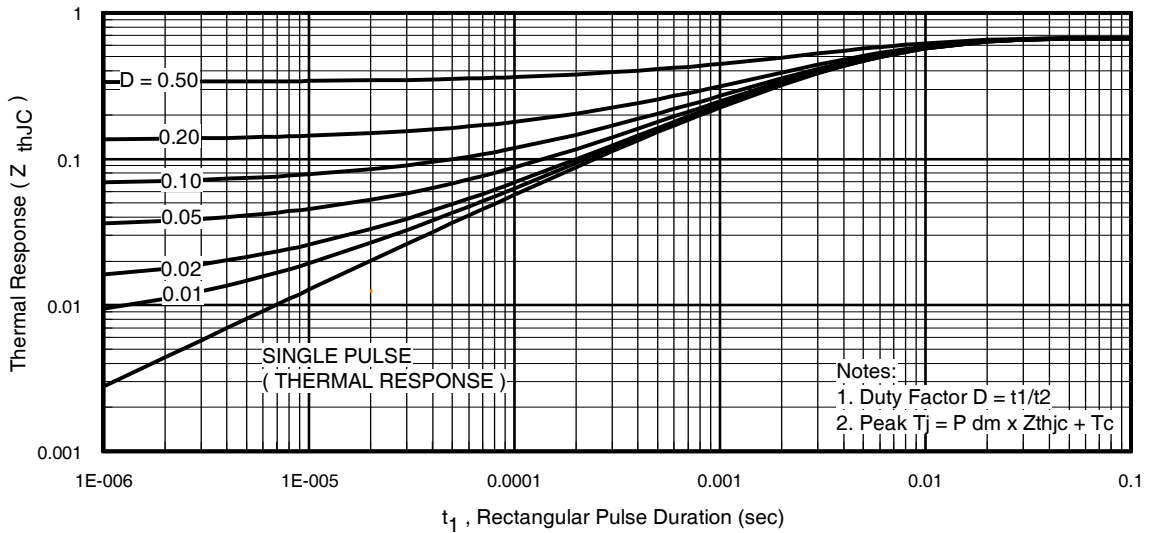
# IRF1404ZGPbF



**Fig 9.** Maximum Drain Current Vs. Case Temperature



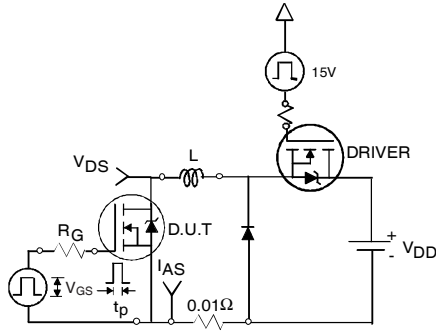
**Fig 10.** Normalized On-Resistance Vs. Temperature



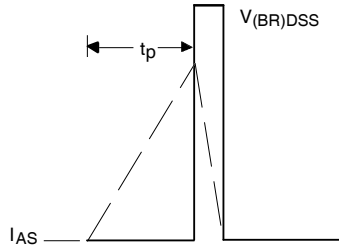
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRF1404ZGPbF

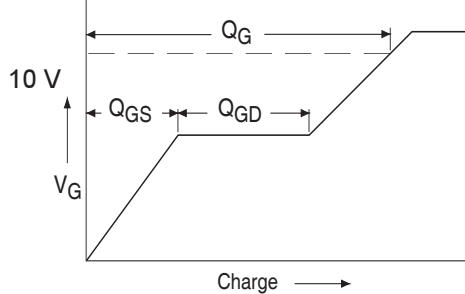
International  
**IR** Rectifier



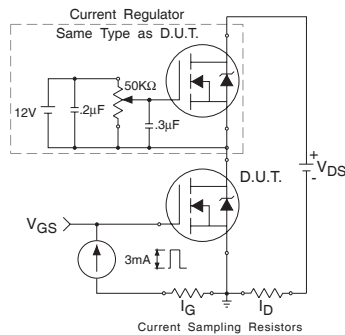
**Fig 12a.** Unclamped Inductive Test Circuit



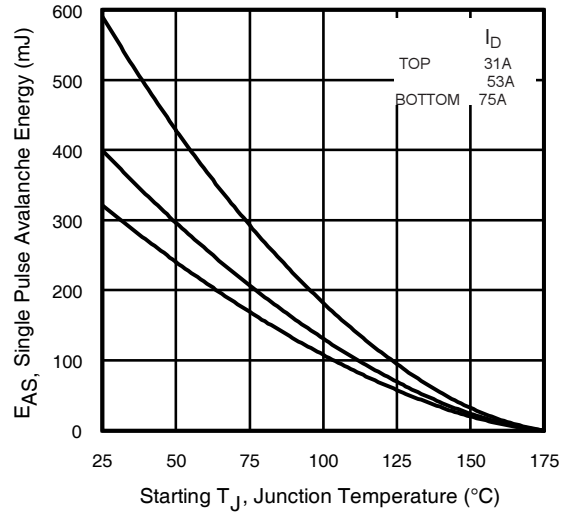
**Fig 12b.** Unclamped Inductive Waveforms



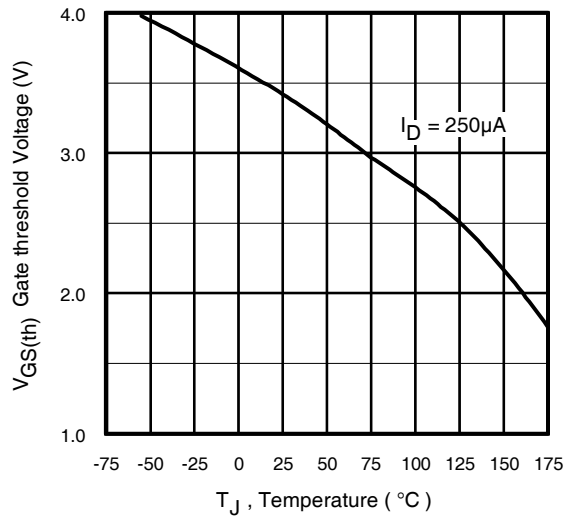
**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit



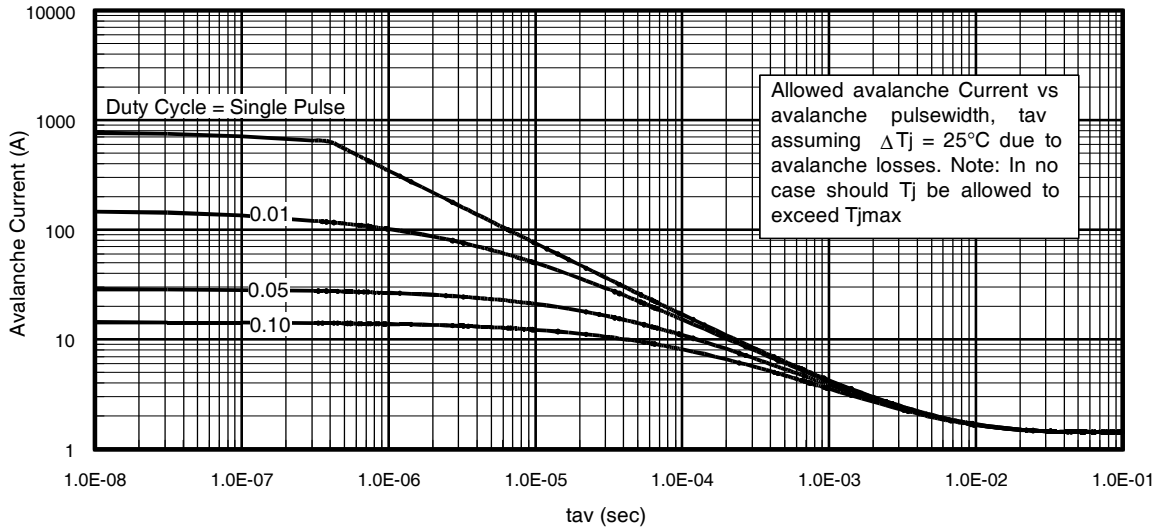
**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



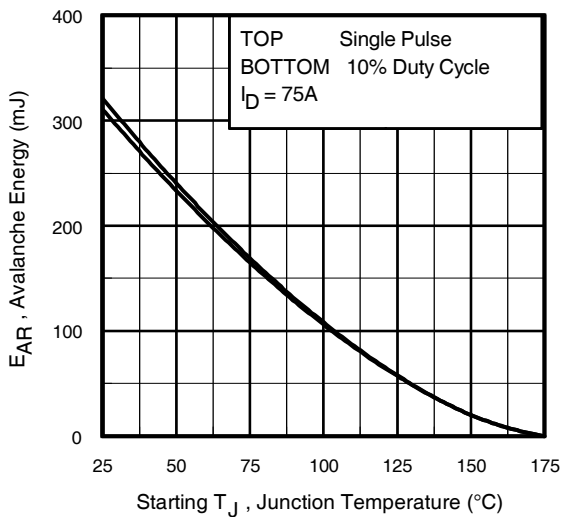
**Fig 14.** Threshold Voltage Vs. Temperature  
 www.irf.com

International  
**IR** Rectifier

# IRF1404ZGPbF



**Fig 15. Typical Avalanche Current Vs.Pulsewidth**



**Fig 16. Maximum Avalanche Energy Vs. Temperature**

**Notes on Repetitive Avalanche Curves , Figures 15, 16:**  
**(For further info, see AN-1005 at www.irf.com)**

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$$

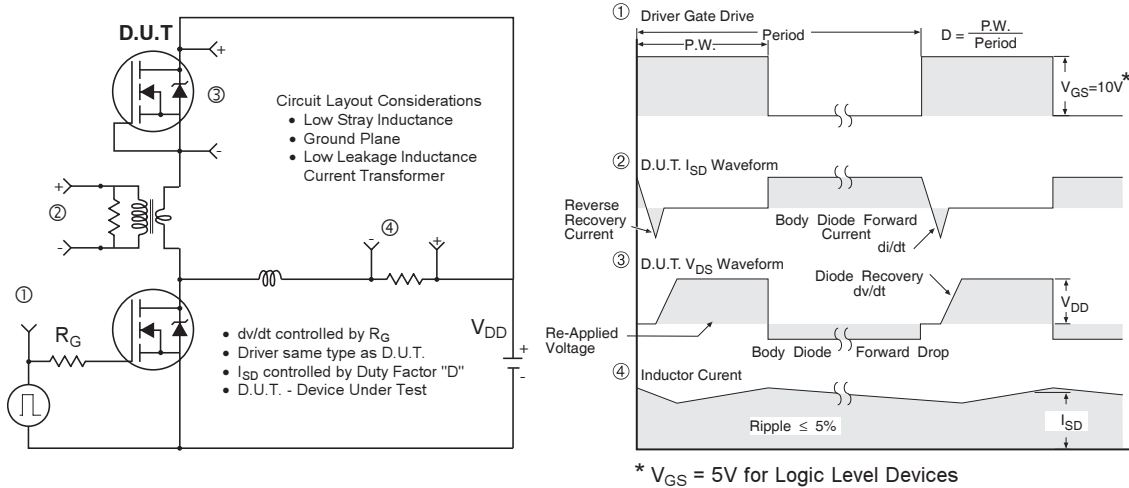
$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

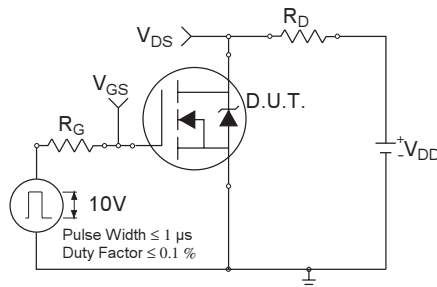


# IRF1404ZGPbF

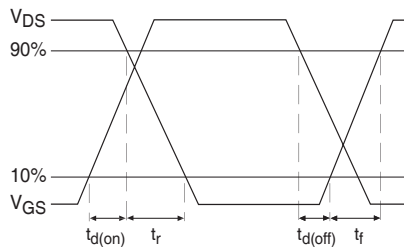
International  
**IR** Rectifier



**Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs**



**Fig 18a. Switching Time Test Circuit**



**Fig 18b. Switching Time Waveforms**



# IRF1404ZGPbF

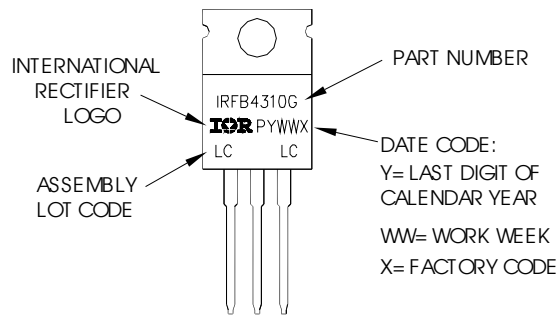
International  
**IR** Rectifier

## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRFB4310GPBF

Note: "G" suffix in part number indicates "Hydrogen - Free"

Note: "P" in assembly line position indicates "Lead - Free"



**Notes:**

1. For an Automotive Qualified version of this part please see <http://www.irf.com/product-info/auto/>
2. For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**Notes:**

- |   |   |
|---|---|
| <ul style="list-style-type: none"> <li>① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).</li> <li>② Limited by <math>T_{Jmax}</math>, starting <math>T_J = 25^\circ C</math>, <math>L = 0.11mH</math>, <math>R_G = 25\Omega</math>, <math>I_{AS} = 75A</math>, <math>V_{GS} = 10V</math>. Part not recommended for use above this value.</li> <li>③ Pulse width <math>\leq 1.0ms</math>; duty cycle <math>\leq 2\%</math>.</li> <li>④ <math>C_{oss}</math> eff. is a fixed capacitance that gives the same charging time as <math>C_{oss}</math> while <math>V_{DS}</math> is rising from 0 to 80% <math>V_{DSS}</math>.</li> </ul> | <ul style="list-style-type: none"> <li>⑤ Limited by <math>T_{Jmax}</math>, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.</li> <li>⑥ This value determined from sample failure population. 100% tested to this value in production.</li> <li>⑦ This is only applied to TO-220AB package.</li> </ul> |
|---|---|

**TO-220AB package is not recommended for Surface Mount Application.**

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
 TAC Fax: (310) 252-7903

Visit us at [www.irf.com](http://www.irf.com) for sales contact information.07/2010

[www.irf.com](http://www.irf.com)